## Notice of References Cited Application/Control No. 10/753,138 Applicant(s)/Patent Under Reexamination DE REGE THESAURO ET AL. Examiner Bryan R Muller Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0182982 A1	12-2002	Li et al.	451/41
	В	US-2002/0086511 A1	07-2002	Hartner et al.	438/608
	С	US-6,454,822 B1	09-2002	Rosenflanz, Anatoly Z	51/309
	D	US-2003/0013387 A1	01-2003	Tsai et al.	451/41
	E	US-2004/0132385 A1	07-2004	Kitayama et al.	451/041
	F	US-2004/0029495 A1	02-2004	Small et al.	451/41
	G	US-2002/0042208 A1	04-2002	Beitel et al.	438/745
	н	US-5,683,443	11-1997	Munshi et al.	607/121
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q			(R)		
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	C							
	>							
	V							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.